

Notice of References Cited

Application/Control No.

10/593,809

Applicant(s)/Patent Under
Reexamination
NARAYAN ET AL.

Examiner

JONATHAN C. LANGMAN

Art Unit

1784

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,057,237	05-2000	Ding et al.	438/687
*	B	US-4,372,989	02-1983	Menzel, Guenther	427/555
*	C	US-6,531,780	03-2003	Woo et al.	257/758
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Marcus, "Electrical and Structural Properties of Epitaxial bcc Tantalum Films", Journal of Applied Physics, Vol. 37, No. 8, 1966, pgs 3121-3127.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.